

FQB8N25 / FQI8N25

250V N-Channel MOSFET

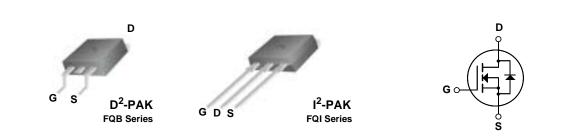
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply.

Features

- 8.0A, 250V, R_{DS(on)} = 0.55Ω @V_{GS} = 10 V
- Low gate charge (typical 12 nC)
- Low Crss (typical 11 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_c = 25°C unless otherwise noted

Symbol	Parameter		FQB8N25 / FQI8N25	Units	
V _{DSS}	Drain-Source Voltage		250	V	
I _D	Drain Current - Continuous ($T_C = 25^\circ$	(O°	8.0	А	
	- Continuous (T _C = 100	D°C)	5.0	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	32	А	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	120	mJ	
I _{AR}	Avalanche Current	(Note 1)	8.0	Α	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	8.7	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns	
P _D	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.13	W	
	Power Dissipation $(T_C = 25^{\circ}C)$		87	W	
	- Derate above 25°C		0.69	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

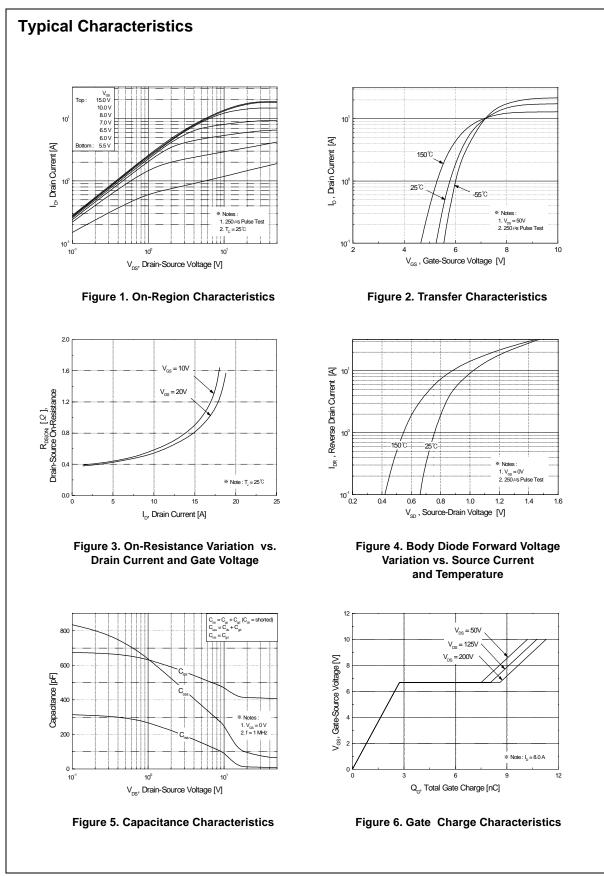
Thermal Characteristics

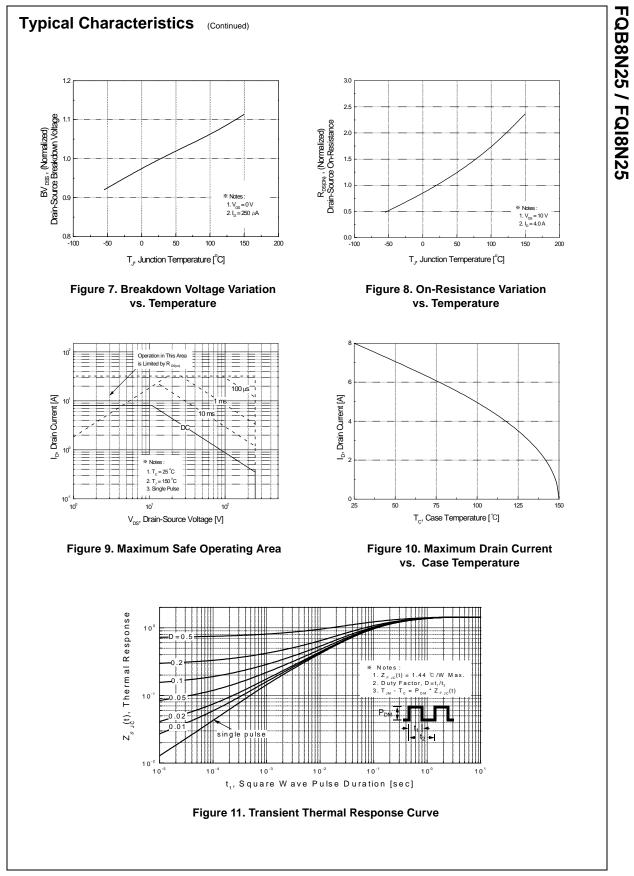
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.44	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W
* When mount	ed on the minimum pad size recommended (PCB Mount)	•	·	

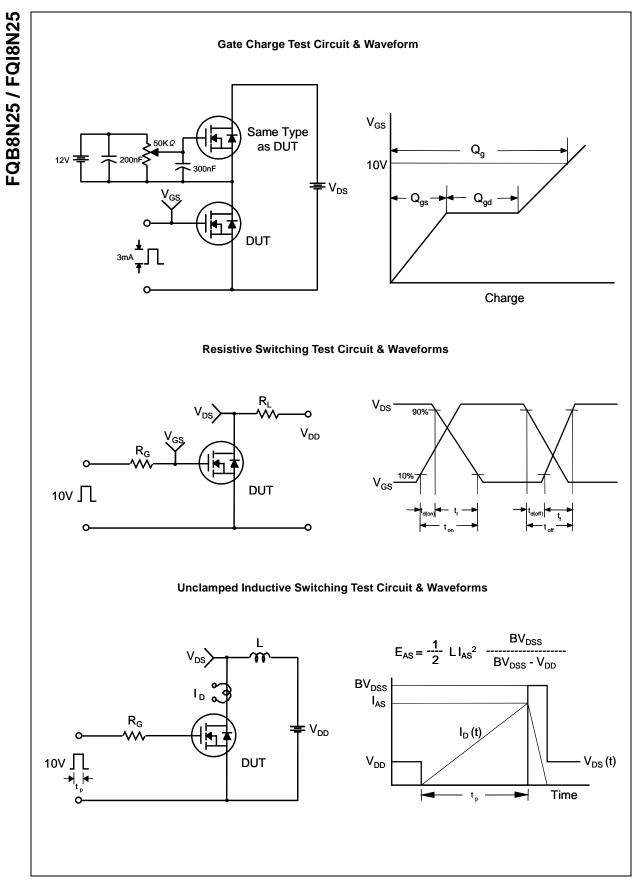
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racteristicsDrain-Source Breakdown VoltageBreakdown Voltage Temperature CoefficientZero Gate Voltage Drain CurrentGate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse	$V_{GS} = 0 V, I_D = 250 \mu A$ $I_D = 250 \mu A, Referenced to 25°$ $V_{DS} = 250 V, V_{GS} = 0 V$ $V_{DS} = 200 V, T_C = 125°C$	250 C	0.24		
Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward	$I_D = 250 \ \mu$ A, Referenced to 25° $V_{DS} = 250 \ V, V_{GS} = 0 \ V$ $V_{DS} = 200 \ V, T_C = 125^{\circ}C$	C			
Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward	$I_D = 250 \ \mu$ A, Referenced to 25° $V_{DS} = 250 \ V, V_{GS} = 0 \ V$ $V_{DS} = 200 \ V, T_C = 125^{\circ}C$		0.24		V
Gate-Body Leakage Current, Forward	V _{DS} = 200 V, T _C = 125°C				V/°C
Gate-Body Leakage Current, Forward				1	μA
				10	μΑ
Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
	V_{GS} = -30 V, V_{DS} = 0 V			-100	nA
acteristics					
	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	3.0		5.0	V
•					
On-Resistance	v _{GS} = 10 V, I _D = 4.0 A		0.42	0.55	Ω
Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 4.0 \text{ A}$ (Note	4)	6.6		S
			1	1	
	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		410	530	pF
Output Capacitance	f = 1.0 MHz		85	110	pF
Reverse Transfer Capacitance			11	15	pF
Turn-On Delay Time	V _{DD} = 125 V, I _D = 8.0 A,		10	30	ns
	$R_{G} = 25 \Omega$				ns
	(Note 4	5)			ns
Turn-Off Fall Time	(14010 4			95	ns
			42	00	
Total Gate Charge	V _{DS} = 200 V, I _D = 8.0 A,		42 12	15	nC
Total Gate Charge Gate-Source Charge	V _{DS} = 200 V, I _D = 8.0 A, V _{GS} = 10 V				nC nC
•			12	15	-
Gate-Source Charge Gate-Drain Charge	V _{GS} = 10 V (Note 4		12 2.7	15 	nC
Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar	V _{GS} = 10 V (Note 4 nd Maximum Ratings		12 2.7	15 	nC nC
Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar Maximum Continuous Drain-Source Dio	V _{GS} = 10 V (Note 4 Ind Maximum Ratings de Forward Current		12 2.7	15 	nC
Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	V _{GS} = 10 V (Note 4 Id Maximum Ratings de Forward Current orward Current	.5)	12 2.7 5.9	15 	nC nC A A
Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar Maximum Continuous Drain-Source Dio	$V_{GS} = 10 \text{ V} $ (Note 4 ad Maximum Ratings de Forward Current orward Current $V_{GS} = 0 \text{ V}, I_S = 8.0 \text{ A}$	5)	12 2.7 5.9	15 8.0	nC nC A
Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	V _{GS} = 10 V (Note 4 Id Maximum Ratings de Forward Current orward Current	 5) 	12 2.7 5.9 	15 8.0 32	nC nC A A
	Forward Transconductance	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 4.0 \text{ A}$ Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 4.0 \text{ A}$ (NoteForward Transconductance $V_{DS} = 50 \text{ V}, I_D = 4.0 \text{ A}$ (NoteCharacteristicsInput Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, I_D = 4.0 \text{ A}$ Input Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ MHz}$ Reverse Transfer Capacitance $f = 1.0 \text{ MHz}$ g Characteristics $V_{DD} = 125 \text{ V}, I_D = 8.0 \text{ A}, R_G = 25 \Omega$ Turn-On Rise Time $V_{DD} = 125 \text{ V}, I_D = 8.0 \text{ A}, R_G = 25 \Omega$	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, \text{ I}_D = 4.0 \text{ A}$ Forward Transconductance $V_{DS} = 50 \text{ V}, \text{ I}_D = 4.0 \text{ A}$ (Note 4)Forward Transconductance $V_{DS} = 50 \text{ V}, \text{ I}_D = 4.0 \text{ A}$ (Note 4)CharacteristicsInput Capacitance $V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1.0 MHzQutput Capacitance $r = 1.0 \text{ MHz}$ Reverse Transfer Capacitance g Characteristics Turn-On Delay Time $V_{DD} = 125 \text{ V}, \text{ I}_D = 8.0 \text{ A},$ $R_G = 25 \Omega$ Turn-Off Delay TimeTurn-Off Delay Time	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 4.0 \text{ A}$ 0.42Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 4.0 \text{ A}$ (Note 4)6.6CharacteristicsInput Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz410Output Capacitance $r = 1.0 \text{ MHz}$ 85Reverse Transfer Capacitance11g CharacteristicsTurn-On Delay Time $V_{DD} = 125 \text{ V}, I_D = 8.0 \text{ A},$ $R_G = 25 \Omega$ 10Turn-Off Delay Time11	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 4.0 \text{ A}$ 0.42 0.55 Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 4.0 \text{ A}$ (Note 4) 6.6 Characteristics Input Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ 410 530 Output Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ 85 110 Reverse Transfer Capacitance $V_{DD} = 125 \text{ V}, I_D = 8.0 \text{ A}, R_G = 25 \Omega$ 10 30 Turn-On Delay Time $V_{DD} = 125 \text{ V}, I_D = 8.0 \text{ A}, R_G = 25 \Omega$ 10 30

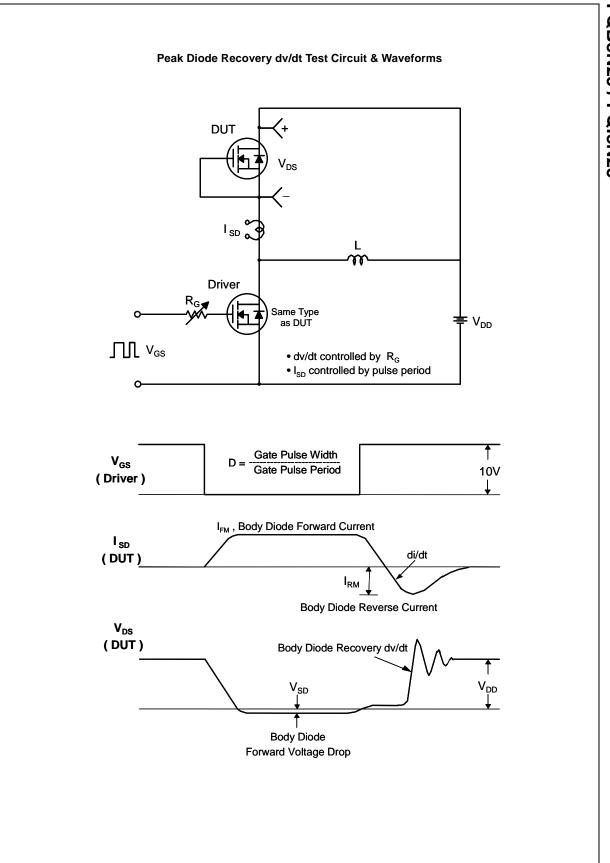
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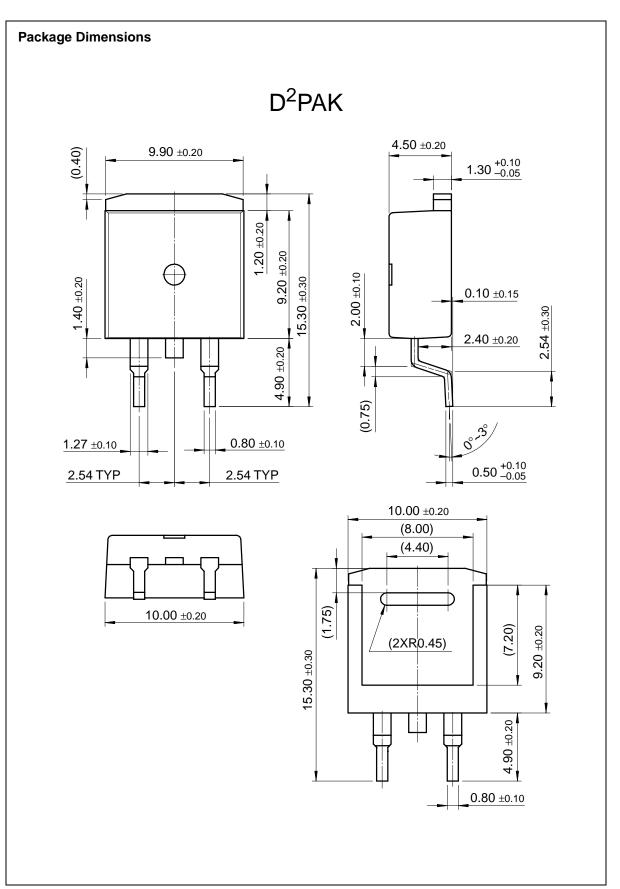


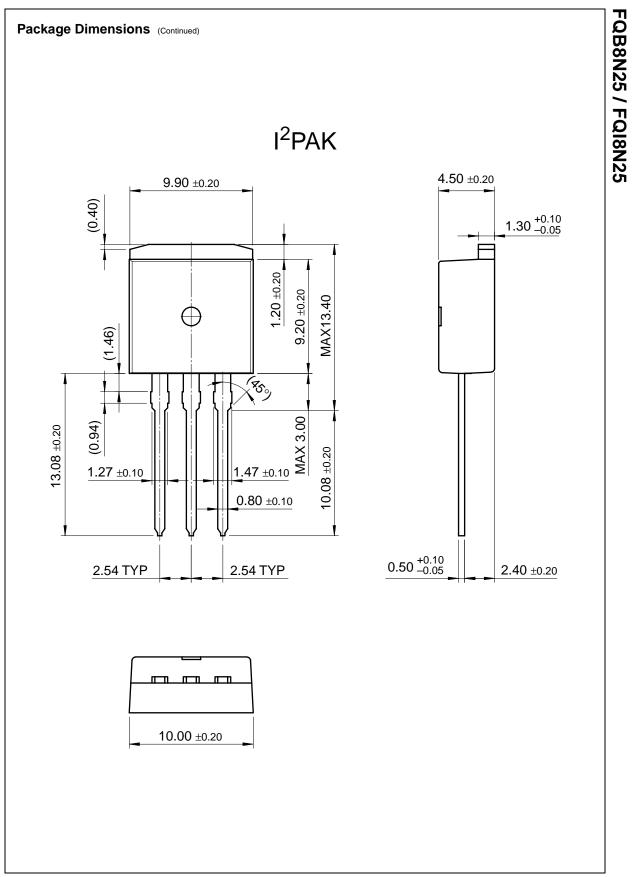


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Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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<u>Memory</u> <u>Optoelectronics</u> <u>Markets and</u>	General description These N-Channel enhancement mode power	<u>e-mail this datasheet</u> [E-	Support Dotted line Distributor and field sales representatives
applications New products Product selection and parametric search	field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially	This page <u>Print version</u>	Dotted line Quality and reliability Dotted line Design tools
Cross-reference search	tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well		
technical information buy products	suited for high efficiency switching DC/DC converters, switch mode power supply.	-	
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Features

company

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQB8N25TM	Full Production	\$0.63	TO-263(D2PAK)	2	TAPE REEL

* 1,000 piece Budgetary Pricing

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